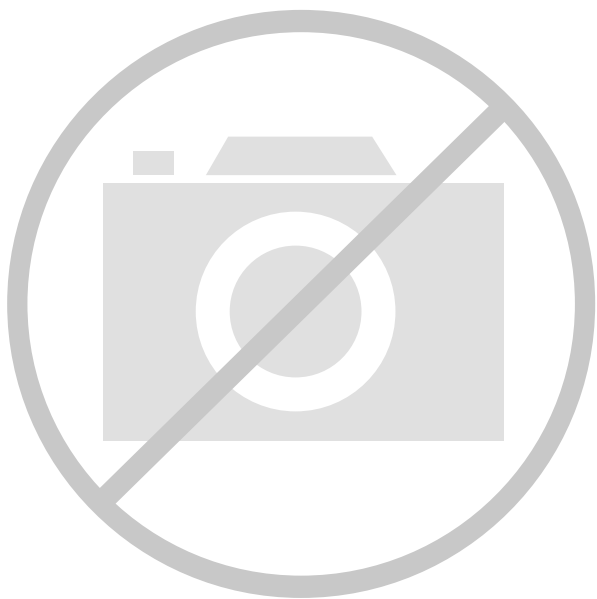




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Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

Product Status	Active
Number of LABs/CLBs	18144
Number of Logic Elements/Cells	-
Total RAM Bits	165888
Number of I/O	317
Number of Gates	1000000
Voltage - Supply	1.425V ~ 1.575V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 70°C (TA)
Package / Case	484-BGA
Supplier Device Package	484-FPBGA (23x23)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/ax1000-1fgg484

Table 2-8 • I/O Standards Supported by the Axcelerator Family

I/O Standard	Input/Output Supply Voltage (VCCI)	Input Reference Voltage (VREF)	Board Termination Voltage (VTT)
LVTTL	3.3	N/A	N/A
LVC MOS 2.5 V	2.5	N/A	N/A
LVC MOS 1.8 V	1.8	N/A	N/A
LVC MOS 1.5 V (JDEC8-11)	1.5	N/A	N/A
3.3V PCI/PCI-X	3.3	N/A	N/A
GTL+ 3.3 V	3.3	1.0	1.2
GTL+ 2.5 V*	2.5	1.0	1.2
HSTL Class 1	1.5	0.75	0.75
SSTL3 Class 1 and II	3.3	1.5	1.5
SSTL2 Class1 and II	2.5	1.25	1.25
LVDS	2.5	N/A	N/A
LVPECL	3.3	N/A	N/A

Note: *2.5 V GTL+ is not supported across the full military temperature range.

Table 2-9 • Supply Voltages

VCCA	VCCI	Input Tolerance	Output Drive Level
1.5 V	1.5 V	3.3 V	1.5 V
1.5 V	1.8 V	3.3 V	1.8 V
1.5 V	2.5 V	3.3 V	2.5 V
1.5 V	3.3 V	3.3 V	3.3 V

Table 2-10 • I/O Features Comparison

I/O Assignment	Clamp Diode	Hot Insertion	5 V Tolerance	Input Buffer	Output Buffer
LVTTL	No	Yes	Yes ¹	Enabled/Disabled	
3.3 V PCI, 3.3 V PCI-X	Yes	No	Yes ^{1, 2}	Enabled/Disabled	
LVC MOS 2.5 V	No	Yes	No	Enabled/Disabled	
LVC MOS 1.8 V	No	Yes	No	Enabled/Disabled	
LVC MOS 1.5 V (JESD8-11)	No	Yes	No	Enabled/Disabled	
Voltage-Referenced Input Buffer	No	Yes	No	Enabled/Disabled	
Differential, LVDS/LVPECL, Input	No	Yes	No	Enabled	Disabled ³
Differential, LVDS/LVPECL, Output	No	Yes	No	Disabled	Enabled ⁴

Notes:

1. Can be implemented with an IDT bus switch.
2. Can be implemented with an external resistor.
3. The OE input of the output buffer must be deasserted permanently (handled by software).
4. The OE input of the output buffer must be asserted permanently (handled by software).

5 V Tolerance

There are two schemes to achieve 5 V tolerance:

1. 3.3 V PCI and 3.3 V PCI-X are the only I/O standards that directly allow 5 V tolerance. To implement this, an internal clamp diode between the input pad and the VCCI pad is enabled so that the voltage at the input pin is clamped, as shown in EQ 3:

$$V_{\text{input}} = V_{\text{CCI}} + V_{\text{diode}} = 3.3 \text{ V} + 0.7 \text{ V} = 4.0 \text{ V}$$

EQ 3

The internal VCCI clamp diode is only enabled while the device is powered on, so the voltage at the input will not be clamped if the VCCI or VCCA are powered off. An external series resistor (~100 Ω) is required between the input pin and the 5 V signal source to limit the current to less than 20 mA (Figure 2-3). The 100 Ω resistor was chosen to meet the input Tr/Tf requirement (Table 2-19 on page 2-21). The GND clamp diode is available for all I/O standards and always enabled.

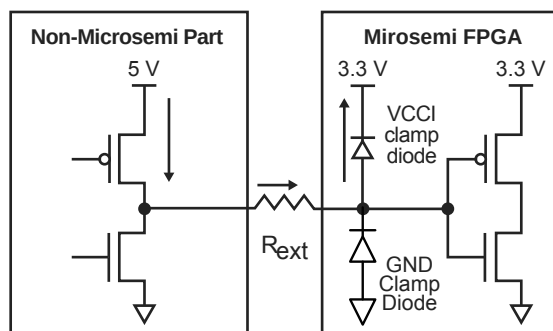


Figure 2-3 • Use of an External Resistor for 5 V Tolerance

2. 5 V tolerance can also be achieved with 3.3 V I/O standards (3.3 V PCI, 3.3 V PCI-X, and LVTTTL) using a bus-switch product (e.g. IDTQS32X2384). This will convert the 5 V signal to a 3.3 V signal with minimum delay (Figure 2-4).

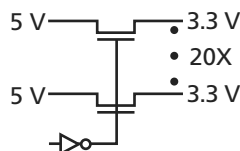


Figure 2-4 • Bus Switch IDTQS32X2384

Simultaneous Switching Outputs (SSO)

When multiple output drivers switch simultaneously, they induce a voltage drop in the chip/package power distribution. This simultaneous switching momentarily raises the ground voltage within the device relative to the system ground. This apparent shift in the ground potential to a non-zero value is known as simultaneous switching noise (SSN) or more commonly, ground bounce.

SSN becomes more of an issue in high pin count packages and when using high performance devices such as the Axcelerator family. Based upon testing, Microsemi recommends that users not exceed eight simultaneous switching outputs (SSO) per each VCCI/GND pair. To ease this potential burden on designers, Microsemi has designed all of the Axcelerator BGAs³ to not exceed this limit with the exception of the CS180, which has an I/O to VCCI/GND pair ratio of nine to one.

Please refer to the *Simultaneous Switching Noise and Signal Integrity* application note for more information.

3. The user should note that in Bank 8 of both AX1000-FG484 and AX500-FG484, there are local violations of this 8:1 ratio.

Timing Characteristics

Table 2-22 • 3.3 V LVTTL I/O Module

Worst-Case Commercial Conditions VCCA = 1.425 V, VCCI = 3.0 V, T_j = 70°C

		–2 Speed		–1 Speed		Std Speed		
Parameter	Description	Min.	Max.	Min.	Max.	Min.	Max.	Units
LVTTTL Output Drive Strength = 1 (8 mA) / Low Slew Rate								
t _{DP}	Input Buffer		1.68		1.92		2.26	ns
t _{PY}	Output Buffer		14.28		16.27		19.13	ns
t _{ENZL}	Enable to Pad Delay through the Output Buffer—Z to Low		15.25		17.37		20.42	ns
t _{ENZH}	Enable to Pad Delay through the Output Buffer—Z to High		14.26		16.24		19.09	ns
t _{ENLZ}	Enable to Pad Delay through the Output Buffer—Low to Z		1.56		1.57		1.58	ns
t _{ENHZ}	Enable to Pad Delay through the Output Buffer—High to Z		1.95		1.96		1.97	ns
t _{IOCLKQ}	Sequential Clock-to-Q for the I/O Input Register		0.67		0.77		0.90	ns
t _{IOCLKY}	Clock-to-output Y for the I/O Output Register and the I/O Enable Register		0.67		0.77		0.90	ns
t _{SUD}	Data Input Set-Up		0.23		0.27		0.31	ns
t _{SUE}	Enable Input Set-Up		0.26		0.30		0.35	ns
t _{HD}	Data Input Hold		0.00		0.00		0.00	ns
t _{HE}	Enable Input Hold		0.00		0.00		0.00	ns
t _{CPWHL}	Clock Pulse Width High to Low	0.39		0.39		0.39		ns
t _{CPWLH}	Clock Pulse Width Low to High	0.39		0.39		0.39		ns
t _{WASYN}	Asynchronous Pulse Width	0.37		0.37		0.37		ns
t _{REASYN}	Asynchronous Recovery Time		0.13		0.15		0.17	ns
t _{HASYN}	Asynchronous Removal Time		0.00		0.00		0.00	ns
t _{CLR}	Asynchronous Clear-to-Q		0.23		0.27		0.31	ns
t _{PRESET}	Asynchronous Preset-to-Q		0.23		0.27		0.31	ns

Timing Characteristics

Table 2-61 • LVPECL I/O Module

Worst-Case Commercial Conditions $V_{CCA} = 1.425\text{ V}$, $V_{CCI} = 3.0\text{ V}$, $T_J = 70^\circ\text{C}$

		–2 Speed		–1 Speed		Std Speed		
Parameter	Description	Min.	Max.	Min.	Max.	Min.	Max.	Units
LVPECL Output Module Timing								
t_{DP}	Input Buffer		1.66		1.89		2.22	ns
t_{PY}	Output Buffer		2.24		2.55		3.00	ns
t_{CLKQ}	Clock-to-Q for the I/O input register		0.67		0.77		0.90	ns
t_{OCLKQ}	Clock-to-Q for the IO output register and the I/O enable register		0.67		0.77		0.90	ns
t_{SUD}	Data Input Set-Up		0.23		0.27		0.31	ns
t_{SUE}	Enable Input Set-Up		0.26		0.30		0.35	ns
t_{HD}	Data Input Hold		0.00		0.00		0.00	ns
t_{HE}	Enable Input Hold		0.00		0.00		0.00	ns
t_{CPWHL}	Clock Pulse Width High to Low	0.39		0.39		0.39		ns
t_{CPWLH}	Clock Pulse Width Low to High	0.39		0.39		0.39		ns
t_{WASYN}	Asynchronous Pulse Width	0.37		0.37		0.37		ns
t_{REASYN}	Asynchronous Recovery Time		0.13		0.15		0.17	ns
t_{HASYN}	Asynchronous Removal Time		0.00		0.00		0.00	ns
t_{CLR}	Asynchronous Clear-to-Q		0.23		0.27		0.31	ns
t_{PRESET}	Asynchronous Preset-to-Q		0.23		0.27		0.31	ns

Table 2-67 • AX500 Predicted Routing Delays
Worst-Case Commercial Conditions $V_{CCA} = 1.425\text{ V}$, $T_J = 70^\circ\text{C}$

		-2 Speed	-1 Speed	Std Speed	
Parameter	Description	Typical	Typical	Typical	Units
Predicted Routing Delays					
t_{DC}	DirectConnect Routing Delay, FO1	0.11	0.12	0.15	ns
t_{FC}	FastConnect Routing Delay, FO1	0.35	0.39	0.46	ns
t_{RD1}	Routing delay for FO1	0.39	0.45	0.53	ns
t_{RD2}	Routing delay for FO2	0.41	0.46	0.54	ns
t_{RD3}	Routing delay for FO3	0.48	0.55	0.64	ns
t_{RD4}	Routing delay for FO4	0.56	0.63	0.75	ns
t_{RD5}	Routing delay for FO5	0.60	0.68	0.80	ns
t_{RD6}	Routing delay for FO6	0.84	0.96	1.13	ns
t_{RD7}	Routing delay for FO7	0.90	1.02	1.20	ns
t_{RD8}	Routing delay for FO8	1.00	1.13	1.33	ns
t_{RD16}	Routing delay for FO16	2.17	2.46	2.89	ns
t_{RD32}	Routing delay for FO32	3.55	4.03	4.74	ns

Table 2-68 • AX1000 Predicted Routing Delays
Worst-Case Commercial Conditions $V_{CCA} = 1.425\text{ V}$, $T_J = 70^\circ\text{C}$

		-2 Speed	-1 Speed	Std Speed	
Parameter	Description	Typical	Typical	Typical	Units
Predicted Routing Delays					
t_{DC}	DirectConnect Routing Delay, FO1	0.12	0.13	0.15	ns
t_{FC}	FastConnect Routing Delay, FO1	0.35	0.39	0.46	ns
t_{RD1}	Routing delay for FO1	0.45	0.51	0.60	ns
t_{RD2}	Routing delay for FO2	0.53	0.60	0.71	ns
t_{RD3}	Routing delay for FO3	0.56	0.63	0.74	ns
t_{RD4}	Routing delay for FO4	0.63	0.71	0.84	ns
t_{RD5}	Routing delay for FO5	0.73	0.82	0.97	ns
t_{RD6}	Routing delay for FO6	0.99	1.13	1.32	ns
t_{RD7}	Routing delay for FO7	1.02	1.15	1.36	ns
t_{RD8}	Routing delay for FO8	1.48	1.68	1.97	ns
t_{RD16}	Routing delay for FO16	2.57	2.91	3.42	ns
t_{RD32}	Routing delay for FO32	4.24	4.81	5.65	ns

Routed Clocks

The routed clock (CLK) is a low-skew network that can drive the clock inputs of all sequential modules in the device (logically equivalent to the HCLK), but has the added flexibility in that it can drive the S0 (Enable), S1, PSET, and CLR input of a register (R-cells and I/O registers) as well as any of the inputs of any C-cell in the device. This allows CLKs to be used not only as clocks, but also for other global signals or high fanout nets. All four CLKs are available everywhere on the chip.

Timing Characteristics

Table 2-75 • AX125 Routed Array Clock Networks

Worst-Case Commercial Conditions $V_{CCA} = 1.425\text{ V}$, $V_{CCI} = 3.0\text{ V}$, $T_J = 70^\circ\text{C}$

		–2 Speed		–1 Speed		Std Speed		Units
Parameter	Description	Min.	Max.	Min.	Max.	Min.	Max.	
Routed Array Clock Networks								
t _{RCKL}	Input Low to High		3.08		3.50		4.12	ns
t _{RCKH}	Input High to Low		3.13		3.56		4.19	ns
t _{RPWH}	Minimum Pulse Width High	0.57		0.64		0.75		ns
t _{RPWL}	Minimum Pulse Width Low	0.52		0.59		0.69		ns
t _{RCKSW}	Maximum Skew		0.35		0.39		0.46	ns
t _{RP}	Minimum Period	1.15		1.31		1.54		ns
t _{RMAX}	Maximum Frequency		870		763		649	MHz

Table 2-76 • AX250 Routed Array Clock Networks

Worst-Case Commercial Conditions $V_{CCA} = 1.425\text{ V}$, $V_{CCI} = 3.0\text{ V}$, $T_J = 70^\circ\text{C}$

		–2 Speed		–1 Speed		Std Speed		Units
Parameter	Description	Min.	Max.	Min.	Max.	Min.	Max.	
Routed Array Clock Networks								
t _{RCKL}	Input Low to High		2.52		2.87		3.37	ns
t _{RCKH}	Input High to Low		2.59		2.95		3.47	ns
t _{RPWH}	Minimum Pulse Width High	0.57		0.64		0.75		ns
t _{RPWL}	Minimum Pulse Width Low	0.52		0.59		0.69		ns
t _{RCKSW}	Maximum Skew		0.35		0.39		0.46	ns
t _{RP}	Minimum Period	1.15		1.31		1.54		ns
t _{RMAX}	Maximum Frequency		870		763		649	MHz

Global Resource Distribution

At the root of each global resource is a PLL. There are two groups of four PLLs for every device. One group, located at the center of the north edge (in the I/O ring) of the chip, sources the four HCLKs. The second group, located at the center of the south edge (again in the I/O ring), sources the four CLKs (Figure 2-38).

Regardless of the type of global resource, HCLK or CLK, each of the eight resources reach the ClockTileDist (CTD) Cluster located at the center of every core tile with zero skew. From the ClockTileDist Cluster, all four HCLKs and four CLKs are distributed through the core tile (Figure 2-39).

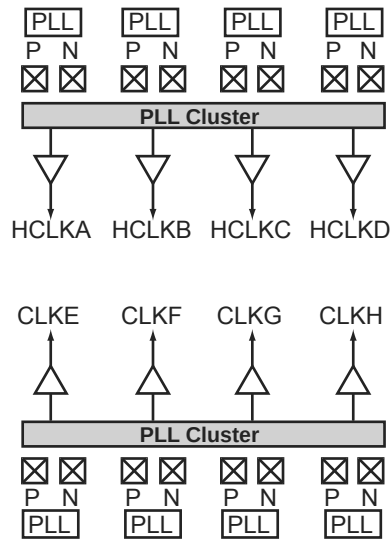


Figure 2-38 • PLL Group

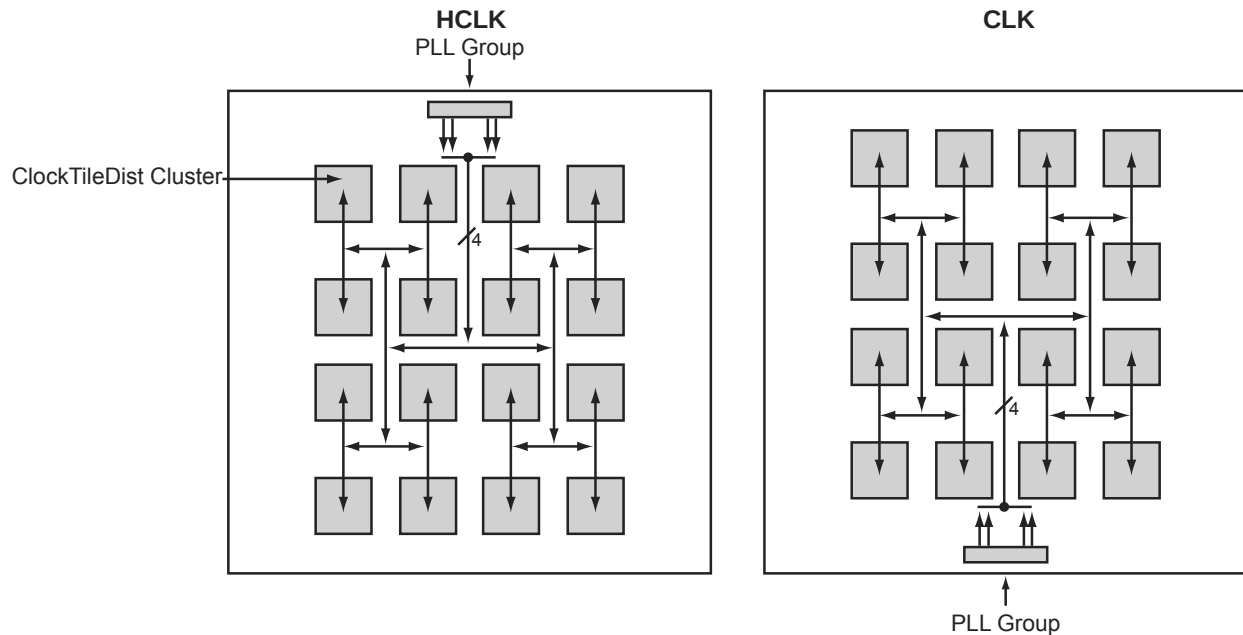


Figure 2-39 • Example of HCLK and CLK Distributions on the AX2000

Table 2-80 • PLL Interface Signals

Signal Name	Type	User Accessible	Allowable Values	Function
RefCLK	Input	Yes		Reference Clock for the PLL
FB	Input	Yes		Feedback port for the PLL
PowerDown	Input	Yes		PLL power down control
			0	PLL powered down
			1	PLL active
DIVI[5:0]	Input	Yes	1 to 64, in unsigned binary notation offset by -1	Sets value for feedback divider (multiplier)
DIVJ[5:0]	Input	Yes		Sets value for CLK1 divider
LowFreq	Input	Yes		Input frequency range selector
			0	50–200 MHz
			1	14–50 MHz
Osc[2:0]	Input	Yes		Output frequency range selector
			XX0	400–1000 MHZ
			001	200–400 MHZ
			011	100–200 MHZ
			101	50–100 MHZ
			111	20–50 MHZ
DelayLine[4:0]	Input	Yes	–15 to +15 (increments), in signed-and-magnitude binary representation	Clock Delay (positive/negative) in increments of 250 ps, with maximum value of ± 3.75 ns
FBMuxSel	Input	No		Selects the source for the feedback input
REFSEL	Input	No		Selects the source for the reference clock
OUTSEL	Input	No		Selects the source for the routed net output
PLLSEL	Input	No		ROOTSEL & PLLSEL are used to select the source of the global clock network
ROOTSEL	Input	No		
Lock	Output	Yes		High value indicates PLL has locked
CLK1	Output	Yes		PLL clock output
CLK2	Output	Yes		PLL clock output

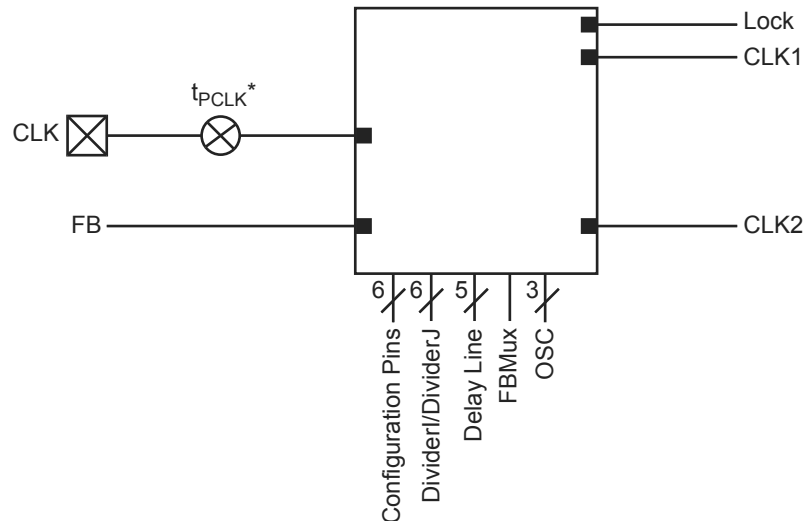
Note: If the input RefClk is taken outside its operating range, the outputs Lock, CLK1 and CLK2 are indeterminate.

User Flow

There are two methods of including a PLL in a design:

- The recommended method of using a PLL is to create custom PLL blocks using Microsemi's macro generator, SmartGen, that can be instantiated in a design.
- The alternative method is to instantiate one of the generic library primitives (PLL or PLLFB) into either a schematic or HDL netlist, using inverters for polarity control and tying all unused address and data bits to ground.

Timing Model



Note: t_{PCLK} is the delay in the clock signal

Figure 2-52 • PLL Model

Table 2-89 • One RAM Block

Worst-Case Commercial Conditions VCCA = 1.425 V, VCCI = 3.0 V, T_J = 70°C

		–2 Speed		–1 Speed		Std Speed		Units
Parameter	Description	Min.	Max.	Min.	Max.	Min.	Max.	
Write Mode								
t _{WDASU}	Write Data Setup vs. WCLK		1.08		1.23		1.45	ns
t _{WDAHD}	Write Data Hold vs. WCLK		0.22		0.25		0.30	ns
t _{WADSU}	Write Address Setup vs. WCLK		1.08		1.23		1.45	ns
t _{WADHD}	Write Address Hold vs. WCLK		0.00		0.00		0.00	ns
t _{WENSU}	Write Enable Setup vs. WCLK		1.08		1.23		1.45	ns
t _{WENHD}	Write Enable Hold vs. WCLK		0.22		0.25		0.30	ns
t _{WCKH}	WCLK Minimum High Pulse Width	0.75		0.75		0.75		ns
t _{WCLK}	WCLK Minimum Low Pulse Width	0.88		0.88		0.88		ns
t _{WCKP}	WCLK Minimum Period	1.63		1.63		1.63		ns
Read Mode								
t _{RADSU}	Read Address Setup vs. RCLK		0.81		0.92		1.08	ns
t _{RADHD}	Read Address Hold vs. RCLK		0.00		0.00		0.00	ns
t _{RENSU}	Read Enable Setup vs. RCLK		0.81		0.92		1.08	ns
t _{RENHD}	Read Enable Hold vs. RCLK		0.00		0.00		0.00	ns
t _{RCK2RD1}	RCLK-to-OUT (Pipelined)		1.32		1.51		1.77	ns
t _{RCK2RD2}	RCLK-to-OUT (Non-Pipelined)		2.16		2.46		2.90	ns
t _{RCLKH}	RCLK Minimum High Pulse Width	0.77		0.77		0.77		ns
t _{RCLKL}	RCLK Minimum Low Pulse Width	0.93		0.93		0.93		ns
t _{RCKP}	RCLK Minimum Period	1.70		1.70		1.70		ns

Note: Timing data for this single block RAM has a depth of 4,096. For all other combinations, use Microsemi's timing software.

TDO

TDO is normally tristated, and it is active only when the TAP controller is in the "Shift_DR" state or "Shift_IR" state. The least significant bit of the selected register (i.e. IR or DR) is clocked out to TDO first by the falling edge of TCK.

TAP Controller

The TAP Controller is compliant with the IEEE Standard 1149.1. It is a state machine of 16 states that controls the Instruction Register (IR) and the Data Registers (such as BSR, IDCODE, USRCODE, BYPASS, etc.). The TAP Controller steps into one of the states depending on the sequence of TMS at the rising edges of TCK.

Instruction Register (IR)

The IR has five bits (IR4 to IR0). At the TRST state, IR is reset to IDCODE. Each time when IR is selected, it goes through "select IR-Scan," "Capture-IR," "Shift-IR," all the way through "Update-IR." When there is no test error, the first five data bits coming out of TDO during the "Shift-IR" will be "10111". If a test error occurs, the last three bits will contain one to three zeroes corresponding to negatively asserted signals: "TDO_ERRORB," "PROBA_ERRORB," and "PROBB_ERRORB." The error(s) will be erased when the TAP is at the "Update-IR" or the TRST state. When in user mode start-up sequence, if the micro-probe has not been used, the "PROBA_ERRORB" is used as a "Power-up done successfully" flag.

Data Registers (DRs)

Data registers are distributed throughout the chip. They store testing/programming vectors. The MSB of a data register is connected to TDI, while the LSB is connected to TDO. There are different types of data registers. Descriptions of the main registers are as follow:

1. IDCODE:
The IDCODE is a 20-bit hard coded JTAG Silicon Signature. It is a hardwired device ID code, which contains the Microsemi identity, part number, and version number in a specific JTAG format.
2. USERCODE:
The USERCODE is a 33-bit programmable register. However, only 20 bits are allocated to use as JTAG Silicon Signature. It is a supplementary identity code for the user to program information to distinguish different programmed parts. USERCODE fuses will read out as "zeroes" when not programmed, so only the "1" bits need to be programmed.
3. Boundary-Scan Register (BSR):
Each I/O contains three Boundary-Scan Cells. Each cell has a shift register bit, a latch, and two MUXes. The boundary-scan cells are used for the Output-enable (E), Output (O), and Input (I) registers. The bit order of the boundary-scan cells for each of them is E-O-I. The boundary-scan cells are then chained serially to form the Boundary-Scan Register (BSR). The length of the BSR is the number of I/Os in the die multiplied by three.
4. Bypass Register (BYR):
This is the "1-bit" register. It is used to shorten the TDI-TDO serial chain in board-level testing to only one bit per device not being tested. It is also selected for all "reserved" or unused instructions.

Probing

Internal activities of the JTAG interface can be observed via the Silicon Explorer II probes: "PRA," "PRB," "PRC," and "PRD."

Special Fuses

Security

Microsemi antifuse FPGAs, with FuseLock technology, offer the highest level of design security available in a programmable logic device. Since antifuse FPGAs are live-at power-up, there is no bitstream that can be intercepted, and no bitstream or programming data is ever downloaded to the device during power-up, thus protecting against device cloning. In addition, special security fuses are hidden

FG256-Pin FBGA		FG256-Pin FBGA		FG256-Pin FBGA	
AX125 Function	Pin Number	AX125 Function	Pin Number	AX125 Function	Pin Number
Bank 6		IO81NB7F7	C2	GND	M12
IO60NB6F6	L4	IO81PB7F7	B1	GND	M5
IO60PB6F6	M4	IO82NB7F7	D2	GND	P13
IO61NB6F6	L3	IO82PB7F7	D3	GND	P3
IO61PB6F6	M3	IO83NB7F7	E3	GND	R15
IO63NB6F6	P2	IO83PB7F7	F3	GND	R2
IO63PB6F6	N2	Dedicated I/O		GND	T1
IO64NB6F6	J4	VCCDA	E4	GND	T16
IO64PB6F6	K4	GND	A1	GND/LP	D4
IO65NB6F6	N1	GND	A16	NC	A11
IO65PB6F6	P1	GND	B15	NC	R11
IO67NB6F6	L2	GND	B2	NC	R5
IO67PB6F6	M2	GND	D15	PRA	D8
IO69NB6F6	L1	GND	E12	PRB	C8
IO69PB6F6	M1	GND	E5	PRC	N9
IO70NB6F6	J3	GND	F11	PRD	P9
IO70PB6F6	K3	GND	F6	TCK	D5
IO71NB6F6	J2	GND	G10	TDI	C6
IO71PB6F6	K2	GND	G7	TDO	C4
Bank 7		GND	G8	TMS	C3
IO72NB7F7	J1	GND	G9	TRST	C5
IO72PB7F7	K1	GND	H10	VCCA	D14
IO73NB7F7	G2	GND	H7	VCCA	F10
IO73PB7F7	H2	GND	H8	VCCA	F4
IO74NB7F7	G3	GND	H9	VCCA	F7
IO74PB7F7	H3	GND	J10	VCCA	F8
IO75NB7F7	E1	GND	J7	VCCA	F9
IO75PB7F7	F1	GND	J8	VCCA	G11
IO76NB7F7	G1	GND	J9	VCCA	G6
IO77NB7F7	E2	GND	K10	VCCA	H11
IO77PB7F7	F2	GND	K7	VCCA	H6
IO78NB7F7	G4	GND	K8	VCCA	J11
IO78PB7F7	H4	GND	K9	VCCA	J6
IO79NB7F7	C1	GND	L11	VCCA	K11
IO79PB7F7	D1	GND	L6	VCCA	K6

FG484		FG484		FG484	
AX1000 Function	Pin Number	AX1000 Function	Pin Number	AX1000 Function	Pin Number
IO246NB7F22	F3	GND	D4	GND	V5
IO246PB7F22	G3	GND	E18	GND	W19
IO250NB7F23	F4	GND	E5	GND	W4
IO250PB7F23	G4	GND	G18	GND	Y20
IO253NB7F23	G5	GND	H15	GND	Y3
IO253PB7F23	G6	GND	H8	GND/LP	G7
IO254NB7F23	D1	GND	J14	PRA	G11
IO254PB7F23	E1	GND	J9	PRB	F11
IO257NB7F23	F5	GND	K10	PRC	T12
IO257PB7F23	E4	GND	K11	PRD	U12
Dedicated I/O		GND	K12	TCK	G8
VCCDA	H7	GND	K13	TDI	F9
GND	A1	GND	L1	TDO	F7
GND	A11	GND	L10	TMS	F6
GND	A12	GND	L11	TRST	F8
GND	A2	GND	L12	VCCA	G17
GND	A21	GND	L13	VCCA	J10
GND	A22	GND	L22	VCCA	J11
GND	AA1	GND	M1	VCCA	J12
GND	AA2	GND	M10	VCCA	J13
GND	AA21	GND	M11	VCCA	J7
GND	AA22	GND	M12	VCCA	K14
GND	AB1	GND	M13	VCCA	K9
GND	AB11	GND	M22	VCCA	L14
GND	AB12	GND	N10	VCCA	L9
GND	AB2	GND	N11	VCCA	M14
GND	AB21	GND	N12	VCCA	M9
GND	AB22	GND	N13	VCCA	N14
GND	B1	GND	P14	VCCA	N9
GND	B2	GND	P9	VCCA	P10
GND	B21	GND	R15	VCCA	P11
GND	B22	GND	R8	VCCA	P12
GND	C20	GND	U16	VCCA	P13
GND	C3	GND	U6	VCCA	T6
GND	D19	GND	V18	VCCA	U17

FG676	
AX500 Function	Pin Number
Bank 0	
IO00NB0F0	F8
IO00PB0F0	E8
IO01NB0F0	A5
IO01PB0F0	A4
IO02NB0F0	E7
IO02PB0F0	E6
IO03NB0F0	D6
IO03PB0F0	D5
IO04NB0F0	B5
IO04PB0F0	C5
IO05NB0F0	B6
IO05PB0F0	C6
IO06NB0F0	C7
IO06PB0F0	D7
IO07NB0F0	A7
IO07PB0F0	A6
IO08NB0F0	C8
IO08PB0F0	D8
IO09NB0F0	F10
IO09PB0F0	F9
IO10NB0F0	B8
IO10PB0F0	B7
IO11NB0F0	D10
IO11PB0F0	E10
IO12NB0F1	B9
IO12PB0F1	C9
IO13NB0F1	F11
IO13PB0F1	G11
IO14NB0F1	D11
IO14PB0F1	E11
IO15NB0F1	B10
IO15PB0F1	C10
IO16NB0F1	A10
IO16PB0F1	A9

FG676	
AX500 Function	Pin Number
IO17NB0F1	F12
IO17PB0F1	G12
IO18NB0F1	C12
IO18PB0F1	C11
IO19NB0F1/HCLKAN	A12
IO19PB0F1/HCLKAP	B12
IO20NB0F1/HCLKBN	C13
IO20PB0F1/HCLKBP	B13
Bank 1	
IO21NB1F2/HCLKCN	C15
IO21PB1F2/HCLKCP	C14
IO22NB1F2/HCLKDN	A15
IO22PB1F2/HCLKDP	B15
IO23NB1F2	F15
IO23PB1F2	G15
IO24NB1F2	B16
IO24PB1F2	A16
IO25NB1F2	A18
IO25PB1F2	A17
IO26NB1F2	D16
IO26PB1F2	E16
IO27NB1F2	F16
IO27PB1F2	G16
IO28NB1F2	C18
IO28PB1F2	C17
IO29NB1F2	B19
IO29PB1F2	B18
IO30NB1F2	D19
IO30PB1F2	C19
IO31NB1F2	F17
IO31PB1F2	E17
IO32NB1F3	B20
IO32PB1F3	A20
IO33NB1F3	B22
IO33PB1F3	B21

FG676	
AX500 Function	Pin Number
IO34NB1F3	D20
IO34PB1F3	C20
IO35NB1F3	D21
IO35PB1F3	C21
IO36NB1F3	D22
IO36PB1F3	C22
IO37NB1F3	F19
IO37PB1F3	E19
IO38NB1F3	B23
IO38PB1F3	A23
IO39NB1F3	E21
IO39PB1F3	E20
IO40NB1F3	D23
IO40PB1F3	C23
IO41NB1F3	D25
IO41PB1F3	C25
Bank 2	
IO42NB2F4	G24
IO42PB2F4	G23
IO43NB2F4	G26
IO43PB2F4	F26
IO44NB2F4	F25
IO44PB2F4	E25
IO45NB2F4	J21
IO45PB2F4	J22
IO46NB2F4	H25
IO46PB2F4	G25
IO47NB2F4	K23
IO47PB2F4	J23
IO48NB2F4	J24
IO48PB2F4	H24
IO49NB2F4	K21
IO49PB2F4	K22
IO50NB2F4	K25
IO50PB2F4	J25

FG1152		FG1152		FG1152	
AX2000 Function	Pin Number	AX2000 Function	Pin Number	AX2000 Function	Pin Number
IO103PB2F9	M28	IO121NB2F11	T27	IO138NB3F12	Y29
IO104NB2F9	M34	IO121PB2F11	T26	IO138PB3F12	W29
IO104PB2F9	L34	IO122NB2F11	T30	IO139NB3F13	Y27
IO105NB2F9	P27	IO122PB2F11	T29	IO139PB3F13	W27
IO105PB2F9	N27	IO123NB2F11	U28	IO140NB3F13	AA33
IO106NB2F9	M32	IO123PB2F11	T28	IO140PB3F13	Y33
IO106PB2F9	M31	IO124NB2F11	T31	IO141NB3F13	Y25
IO107NB2F10	P25	IO124PB2F11	T32	IO141PB3F13	Y24
IO107PB2F10	P26	IO125NB2F11	U24	IO142NB3F13	AA31
IO108NB2F10	N33	IO125PB2F11	U25	IO142PB3F13	Y31
IO108PB2F10	M33	IO126NB2F11	U33	IO143NB3F13	AA28
IO109NB2F10	P29	IO126PB2F11	U34	IO143PB3F13	Y28
IO109PB2F10	N29	IO127NB2F11	U26	IO144NB3F13	AA34
IO110NB2F10	P30	IO127PB2F11	U27	IO144PB3F13	Y34
IO110PB2F10	N30	IO128NB2F11	U31	IO145NB3F13	AA26
IO111NB2F10	R24	IO128PB2F11	U32	IO145PB3F13	Y26
IO111PB2F10	R25	Bank 3		IO146NB3F13	AA29
IO112NB2F10	P31	IO129NB3F12	V29	IO146PB3F13	AA30
IO112PB2F10	N31	IO129PB3F12	U29	IO147NB3F13	AB30
IO113NB2F10	R28	IO130NB3F12	V31	IO147PB3F13	AB29
IO113PB2F10	P28	IO130PB3F12	V32	IO148NB3F13	AB32
IO114NB2F10	P32	IO131NB3F12	V24	IO148PB3F13	AA32
IO114PB2F10	N32	IO131PB3F12	V25	IO149NB3F13	AB27
IO115NB2F10	R30	IO132NB3F12	W28	IO149PB3F13	AA27
IO115PB2F10	R29	IO132PB3F12	V28	IO150NB3F14	AC31
IO116NB2F10	P34	IO133NB3F12	W26	IO150PB3F14	AB31
IO116PB2F10	P33	IO133PB3F12	V26	IO151NB3F14	AD33
IO117NB2F10	R27	IO134NB3F12	W33	IO151PB3F14	AC33
IO117PB2F10	R26	IO134PB3F12	V33	IO152NB3F14	AC28
IO118NB2F11	R34	IO135NB3F12	W25	IO152PB3F14	AB28
IO118PB2F11	R33	IO135PB3F12	W24	IO153NB3F14	AB25
IO119NB2F11	T24	IO136NB3F12	W31	IO153PB3F14	AA25
IO119PB2F11	T25	IO136PB3F12	W32	IO154NB3F14	AD32
IO120NB2F11	T33	IO137NB3F12	Y30	IO154PB3F14	AC32
IO120PB2F11	T34	IO137PB3F12	W30	IO155NB3F14	AD29

CQ256		CQ256	
AX2000 Function	Pin Number	AX2000 Function	Pin Number
VCCA	4	VCCDA	224
VCCA	22	VCCDA	236
VCCA	42	VCCDA	237
VCCA	61	VCCDA	251
VCCA	63	VCCIB0	230
VCCA	84	VCCIB0	244
VCCA	108	VCCIB1	200
VCCA	127	VCCIB1	206
VCCA	131	VCCIB1	218
VCCA	150	VCCIB2	164
VCCA	170	VCCIB2	176
VCCA	189	VCCIB2	182
VCCA	191	VCCIB3	138
VCCA	212	VCCIB3	144
VCCA	238	VCCIB3	156
VCCDA	2	VCCIB4	102
VCCDA	32	VCCIB4	114
VCCDA	66	VCCIB4	120
VCCDA	67	VCCIB5	72
VCCDA	86	VCCIB5	78
VCCDA	87	VCCIB5	90
VCCDA	94	VCCIB6	36
VCCDA	95	VCCIB6	48
VCCDA	96	VCCIB6	54
VCCDA	106	VCCIB7	10
VCCDA	107	VCCIB7	16
VCCDA	126	VCCIB7	28
VCCDA	130	VPUMP	195
VCCDA	160		
VCCDA	194		
VCCDA	196		
VCCDA	214		
VCCDA	215		
VCCDA	222		
VCCDA	223		

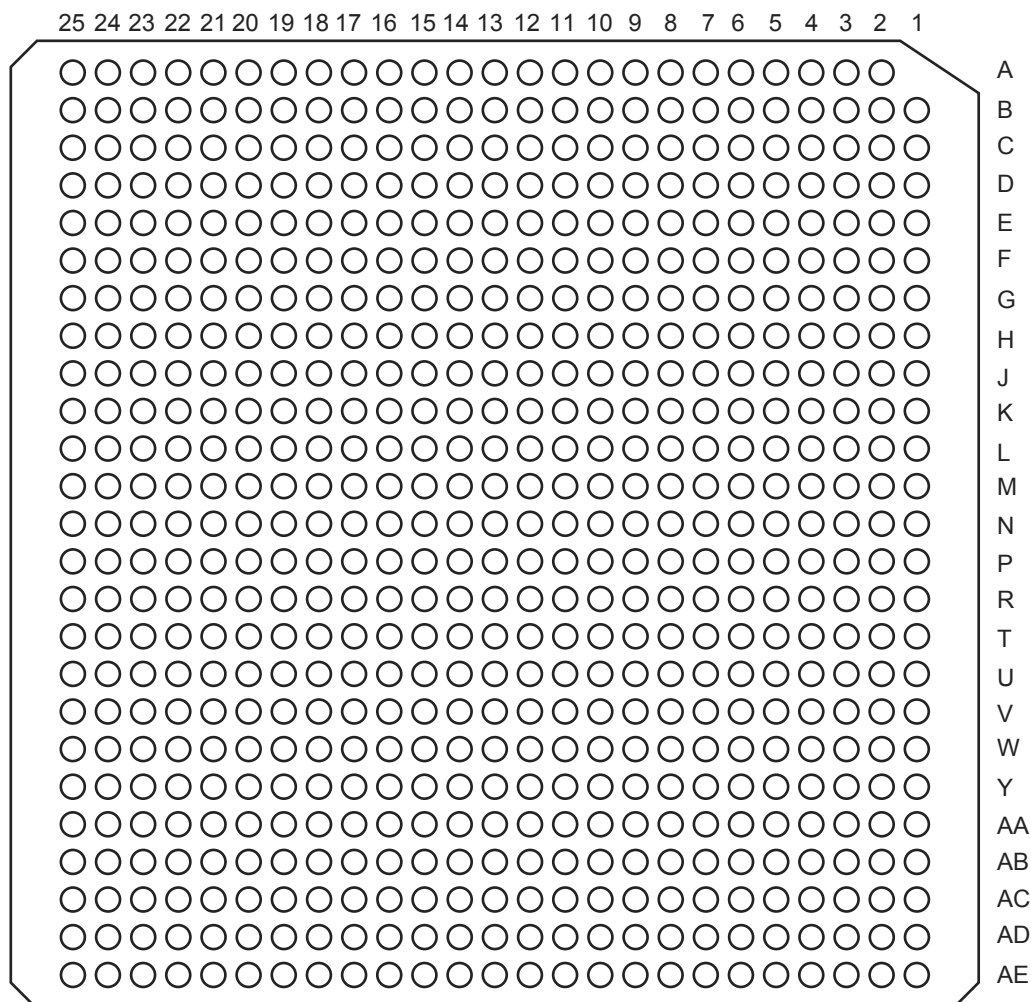
CQ352	
AX250 Function	Pin Number
Bank 0	
IO00NB0F0	341
IO00PB0F0	342
IO01NB0F0	343
IO02NB0F0	337
IO02PB0F0	338
IO04NB0F0	335
IO04PB0F0	336
IO06NB0F0	331
IO06PB0F0	332
IO08NB0F0	325
IO08PB0F0	326
IO10NB0F0	323
IO10PB0F0	324
IO12NB0F0/HCLKAN	319
IO12PB0F0/HCLKAP	320
IO13NB0F0/HCLKBN	313
IO13PB0F0/HCLKBP	314
Bank 1	
IO14NB1F1/HCLKCN	305
IO14PB1F1/HCLKCP	306
IO15NB1F1/HCLKDN	299
IO15PB1F1/HCLKDP	300
IO16NB1F1	289
IO16PB1F1	290
IO17NB1F1	295
IO17PB1F1	296
IO18NB1F1	287
IO18PB1F1	288
IO20NB1F1	283
IO20PB1F1	284
IO22NB1F1	277
IO22PB1F1	278
IO23NB1F1	281
IO23PB1F1	282

CQ352	
AX250 Function	Pin Number
IO24NB1F1	275
IO24PB1F1	276
IO25NB1F1	271
IO25PB1F1	272
IO27NB1F1	269
IO27PB1F1	270
Bank 2	
IO29NB2F2	261
IO29PB2F2	262
IO30NB2F2	259
IO30PB2F2	260
IO31NB2F2	255
IO31PB2F2	256
IO33NB2F2	249
IO33PB2F2	250
IO34NB2F2	253
IO34PB2F2	254
IO35NB2F2	247
IO35PB2F2	248
IO36NB2F2	243
IO36PB2F2	244
IO37NB2F2	241
IO37PB2F2	242
IO38NB2F2	237
IO38PB2F2	238
IO39NB2F2	235
IO39PB2F2	236
IO41NB2F2	231
IO41PB2F2	232
IO42NB2F2	229
IO42PB2F2	230
IO43NB2F2	225
IO43PB2F2	226
IO44NB2F2	223
IO44PB2F2	224

CQ352	
AX250 Function	Pin Number
Bank 3	
IO45NB3F3	217
IO45PB3F3	218
IO46NB3F3	219
IO46PB3F3	220
IO47NB3F3	213
IO47PB3F3	214
IO48NB3F3	211
IO48PB3F3	212
IO49NB3F3	207
IO49PB3F3	208
IO51NB3F3	205
IO51PB3F3	206
IO52NB3F3	201
IO52PB3F3	202
IO53NB3F3	199
IO53PB3F3	200
IO54NB3F3	195
IO54PB3F3	196
IO55NB3F3	193
IO55PB3F3	194
IO56NB3F3	187
IO56PB3F3	188
IO57NB3F3	189
IO57PB3F3	190
IO59NB3F3	183
IO59PB3F3	184
IO60NB3F3	181
IO60PB3F3	182
IO61NB3F3	179
IO61PB3F3	180
Bank 4	
IO62NB4F4	172
IO62PB4F4	173
IO64NB4F4	166

CQ352		CQ352		CQ352	
AX500 Function	Pin Number	AX500 Function	Pin Number	AX500 Function	Pin Number
GND	21	GND	240	TDI	348
GND	27	GND	246	TDO	347
GND	33	GND	252	TMS	350
GND	39	GND	258	TRST	351
GND	45	GND	264	VCCA	3
GND	51	GND	265	VCCA	14
GND	57	GND	274	VCCA	32
GND	63	GND	280	VCCA	56
GND	69	GND	286	VCCA	74
GND	75	GND	292	VCCA	87
GND	81	GND	298	VCCA	102
GND	88	GND	310	VCCA	114
GND	89	GND	322	VCCA	150
GND	97	GND	330	VCCA	162
GND	103	GND	334	VCCA	175
GND	109	GND	340	VCCA	191
GND	115	GND	345	VCCA	209
GND	121	GND/LP	352	VCCA	233
GND	133	NC	91	VCCA	251
GND	145	NC	117	VCCA	263
GND	151	NC	130	VCCA	279
GND	157	NC	131	VCCA	291
GND	163	NC	148	VCCA	329
GND	169	NC	174	VCCA	339
GND	176	NC	268	VCCDA	2
GND	177	NC	294	VCCDA	44
GND	186	NC	307	VCCDA	90
GND	192	NC	308	VCCDA	116
GND	198	NC	327	VCCDA	132
GND	204	NC	328	VCCDA	149
GND	210	PRA	312	VCCDA	178
GND	216	PRB	311	VCCDA	221
GND	222	PRC	135	VCCDA	266
GND	228	PRD	134	VCCDA	293
GND	234	TCK	349	VCCDA	309

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Note

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